

<b>Form 1449 (Modified)</b>  <b>Information Disclosure Statement By Applicant</b>  (Use Several Sheets if Necessary)	<b>Atty Docket No.:</b>	XENOP009
	<b>Application No.:</b>	10/606,976
	<b>Applicant:</b>	STEARNS et al.
	<b>Filing Date:</b>	June 25, 2003
	<b>Art Unit:</b>	3768
		Page 1 of 2

## U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	1.	5,917,190	06/29/99	Yodh et al.			07/25/96
	2.						
	3.						
	4.						

## Foreign Patent or Published Foreign Patent Application

Examiner Initial		Document No.	Publication Date	Country or Patent Office	Class	Sub-Class	Translation	
							Yes	No
	5.	2000-500228	01/11/00	JP			No	
	6.	10-510626	10/13/98	JP			No	
	7.	96/16596	06/06/96	PCT			Yes	
	8.	09-504964	05/20/97	JP			No	
	9.	11-173976	07/02/99	JP			Yes	
	10.	08-136448	05/31/96	JP			Yes	
	11.	06-129984	05/13/94	JP			Yes	
	12.	2002-511778	04/16/02	JP			No	

## Other Documents

Examiner Initial	No.	Author, Title, Place (e.g. Journal) of Publication, Date
	13.	TAULER et al., "Multivariate Curve Resolution Applied to Spectral Data from Multiple Runs of an Industrial Process," Analytical Chemistry, Vol. 65, No. 15, August 1, 1993, pp. 2040-2047
	14.	JAUMOT et al., "A graphical user-friendly interface for MCR-ALS: a new tool for multivariate curve resolution in MATLAB," Chemometrics and Intelligent Laboratory Systems 76, 2005, pp. 101-110.
	15.	WENTZELL et al., "Multivariate curve resolution of time course microarray data," BMC Bioinformatics 2006, 7:343, submitted March 18, 2006, published July 13, 2006.
	16.	DUPONCHEL et al., "Multivariate curve resolution methods in imaging spectroscopy: influence of extraction methods and instrumental perturbations," J. Chem. Inf. Comput. Sci., Vol. 43, No. 6, 2003, pp. 2057-2067.
	17.	Notice of Allowance dated March 19, 2008 from U.S. Application No. 10/151,463.
	18.	European Examination Report dated April 8, 2008 from EP Patent Application No. 06013492.1.

<b>Examiner</b>	<b>Date Considered</b>
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /V.G./

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		Page 2 of 2

	19.	Chinese Office Action dated April 4, 2008 from Chinese Patent Application No. 03821121.1.
	20.	Office Action dated June 9, 2008 from Japanese Patent Application No. 2002-589773.
	21.	Office Action dated August 6, 2008 from U.S. Patent Application No. 11/733,358.
	22.	
	23.	

<b>Examiner</b> /Vani Gupta/	<b>Date Considered</b> 12/08/2008
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